

Description

The FDD5N50NZTM uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

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TO-252-2L (DPAK)

General Features

 $V_{DS} = 500V I_{D} = 5 A$

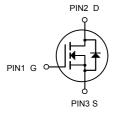
 $R_{DS(ON)} < 1.3 \Omega$ @ $V_{GS}=10V$

Application

PWM Application

Load switch

Power Management



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
FDD5N50NZTM	TO-252-2L (DPAK)	HXY MOSFET	2500

Absolute Maximum Ratings (T_c=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vos	Drain-Source Voltage	500	V
Vgs	Gate-Source Voltage	±30	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	5	А
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	3	А
Ірм	Pulsed Drain Current ²	20	А
EAS	Single Pulse Avalanche Energy ³	137	mJ
P _D @T _C =25°C	Total Power Dissipation ⁴	83	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
R _θ JA	Thermal Resistance Junction-Ambient ¹	33	°C/W
R _θ Jc	Thermal Resistance Junction-Case ¹	1.5 °C/\	



Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	500	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 500V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 30V$	-	-	±100	nA
On Cha	racteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3.4	3.6	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 2.5A$	-	1.30	1.50	Ω
Dynam	ic Characteristics					
C _{iss}	Input Capacitance		-	582	-	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = 25V$, f = 1MHz	-	42	-	pF
C _{rss}	Reverse Transfer Capacitance	I – HVIFIZ	-	4	-	pF
Qg	Total Gate Charge		-	14	-	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 250V, I_{D} = 2A$	-	3.3	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} 2001, by 211	-	4	-	nC
Switchi	ing Characteristics					
t _{d(on)}	Turn-On DelayTime		-	12	-	ns
t _r	Turn-On Rise Time	V _{GS} = 10V, V _{DD} = 240V	-	17	-	ns
t _{d(off)}	Turn-Off DelayTime	$I_D = 2A$, $R_{GEN} = 24\Omega$	-	45	-	ns
t _f	Turn-Off Fall Time		-	25	-	ns
Drain-S	Source Diode Characteristics and M	ax Ratings				
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	5	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	20	Α
V _{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 5A$	-	-	1.2	V
trr	Body Diode Reverse Recovery Time	L = EA di/dt = 400 A /:	-	340	-	ns
Qrr	Body Diode Reverse Recovery Charge	I _F = 5A, di/dt = 100A/us	-	2.9	-	μC

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- 2. E_{AS} condition: Starting T_J =25C, V_{DD} =50V, V_G =10V, R_G =25ohm, L=10mH, I_{AS} =5.3A
- 3. $R\theta JA$ is measured with the device mounted on a minimum recommended pad of 2oz copper FR4 PCB
- 4. Pulse Test: Pulse Width≤300μs, Duty Cycle≤0.5%.



Typical Characteristics

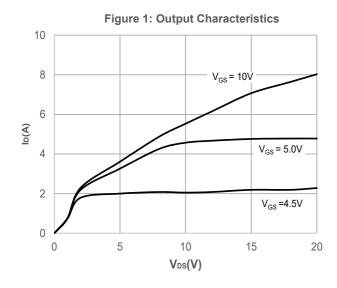
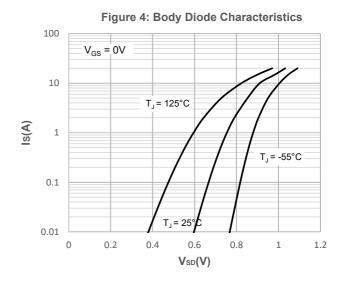
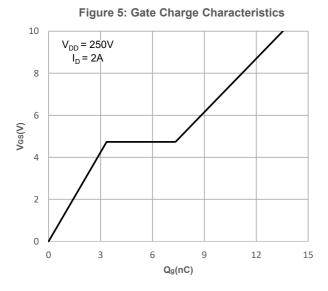


Figure 2: Typical Transfer Characteristics 8 V_{DS} = 5V 6 $T_J = -55^{\circ}C$ **∀**9 2 T_J = 25°C T_J = 125°C 0 0 2 3 5 4 6 8 Vgs(V)

Figure 3: On-resistance vs. Drain Current

3000
2500
1500
1000
500
0
2 4 6 8
Ib(A)





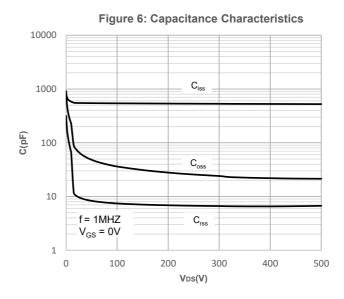




Figure 7: Normalized Breakdown voltage vs. **Junction Temperature**

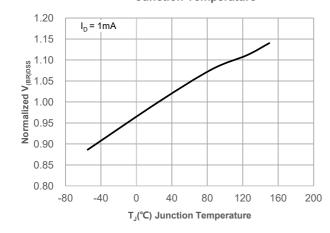


Figure 9: Maximum Safe Operating Area

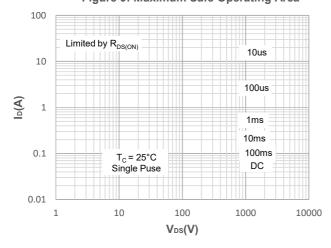


Figure 11: Normalized Maximum Transient Thermal Impedance

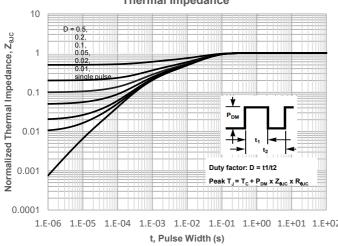


Figure 8: Normalized on Resistance vs. **Junction Temperature**

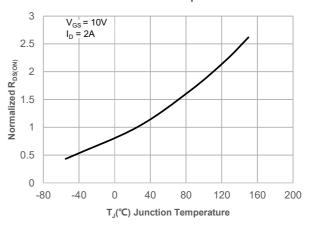


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

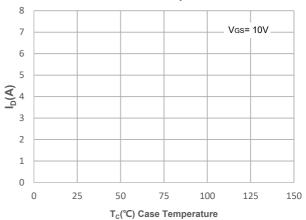
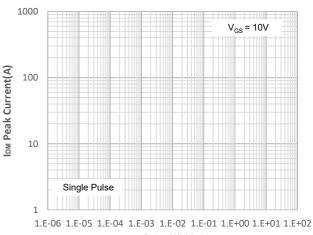


Figure 12: Peak Current Capacity



t, Pulse Width (s)

Test Circuit

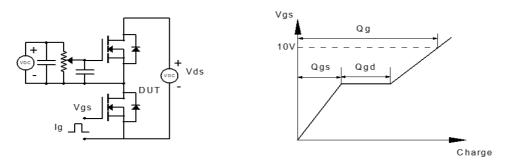


Figure 1: Gate Charge Test Circuit & Waveform

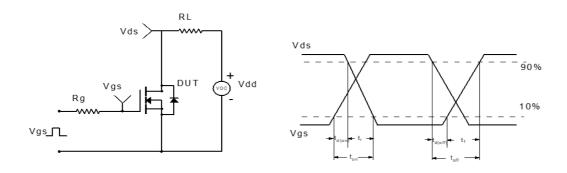


Figure 2: Resistive Switching Test Circuit & Waveform

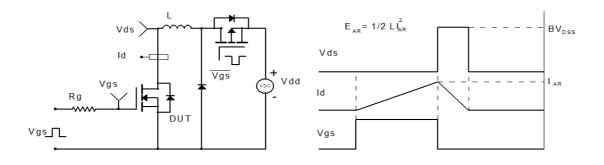


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

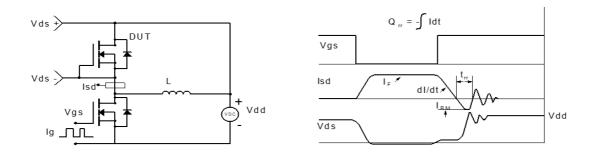
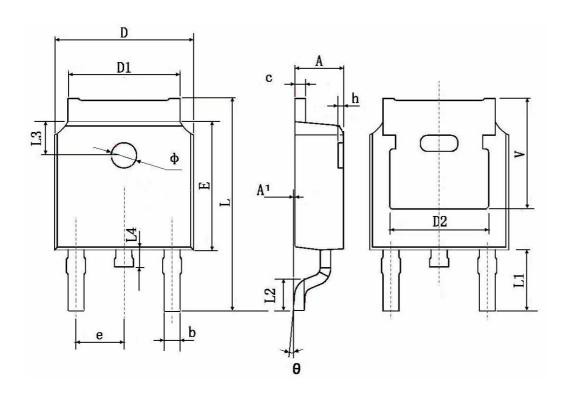


Figure 4: Diode Recovery Test Circuit & Waveform



TO-252-2L(DPAK) Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
А	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
С	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	0.483 TYP.		0.190 TYP.	
Е	6.000	6.200	0.236	0.244
е	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600	TYP.	0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Ф	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350	TYP.	0.211 TYP.	

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